



# **General Description**

The WSD3095DN56 is the highest performance trench N-ch MOSFET with extreme high cell density , which provide excellent RDSON and gate charge for most of the synchronous buck converter applications .

The WSD3095DN56 meet the RoHS and Green Product requirement 100% EAS guaranteed with full function reliability approved.

#### **Features**

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- 100% EAS Guaranteed
- Green Device Available

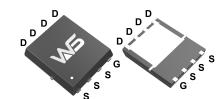
### **Product Summery**

BVDSS	RDSON	ID
30V	3.5mΩ	95A

#### **Applications**

- Battery protection
- Load switch
- Uninterruptible power supply

# **DFN5X6-8 Pin Configuration**





### Absolute Maximum Ratings (Tc=25°Cunless otherwise noted)

Symbol	Parameter	Rating	Units	
Vos	Drain-Source Voltage	30	V	
Vgs	Gate-Source Voltage	±20	V	
I <b>□@T</b> c <b>=25</b> °C	Continuous Drain Current, Vos @ 10V1	90	Α	
I <b>⊳@T</b> c=100°C	Continuous Drain Current, Vos @ 10V1	51	Α	
I <b>□@T</b> A= <b>25</b> °C	Continuous Drain Current, Vos @ 10V1	15	А	
I <b>□@T</b> A=70°C	Continuous Drain Current, Vos @ 10V1	12	А	
Ідм	Pulsed Drain Current2	160	А	
EAS	Single Pulse Avalanche Energy <sub>3</sub>	115.2	mJ	
las	Avalanche Current	48	Α	
P <b>o@T</b> c= <b>25</b> ℃	Total Power Dissipation <sub>4</sub>	59	W	
P <b>o@T</b> a=25℃	725℃ Total Power Dissipation4		W	
Тѕтс	Storage Temperature Range	-55 to 150	$^{\circ}\! \mathbb{C}$	
TJ	Operating Junction Temperature Range	-55 to 150	°C	
Reja	Thermal Resistance Junction-Ambient 1	62	°C/W	
Rejc	Thermal Resistance Junction-Case <sub>1</sub>	2.1	°C/W	



# Electrical Characteristics (T<sub>J</sub>=25°C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BVDSS	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =250uA	30			V
△BVDSS/△TJ	BVDSS Temperature Coefficient	Reference to 25°C , I□=1mA		0.028		V/°C
RDS(ON)	Static Drain-Source On-Resistance	Vgs=10V , ID=30A		3.5	5.5	mΩ
		Vgs=4.5V , Ip=15A		6.5	8.5	
VGS(th)	Gate Threshold Voltage		1.0	1.6	2.5	V
$\triangle V$ GS(th)	Temperature Coefficient	Vgs=Vps , Ip =250uA		-6.16		mV/°C
IDSS	Drain-Source Leakage Current	V <sub>DS</sub> =24V , V <sub>GS</sub> =0V , T <sub>J</sub> =25°C			1	- uA
		V <sub>DS</sub> =24V , V <sub>GS</sub> =0V , T <sub>J</sub> =55°C			5	
IGSS	Gate-Source Leakage Current	Vgs=±20V , Vps=0V			±100	nA
gfs	Forward Transconductance	V <sub>DS</sub> =5V , I <sub>D</sub> =30A		22		S
Rg	Gate Resistance	V <sub>DS</sub> =0V , V <sub>GS</sub> =0V , f=1MHz		1.7	3.4	Ω
Qg	Total Gate Charge (4.5V)	V <sub>DS</sub> =15V , V <sub>GS</sub> =4.5V , I <sub>D</sub> =15A		20		nC
Qgs	Gate-Source Charge			7.6		
Qgd	Gate-Drain Charge			7.2		
Td(on)	Turn-On Delay Time			7.8		ns
Tr	Rise Time	V <sub>DD</sub> =15V , V <sub>GS</sub> =10V , R <sub>G</sub> =3.3Ω		15		
Td(off)	Turn-Off Delay Time	I <sub>D</sub> =15A		37.3		
Tf	Fall Time			10.6		
Ciss	Input Capacitance			2295		pF
Coss	Output Capacitance	V <sub>DS</sub> =15V , V <sub>GS</sub> =0V , f=1MHz		267		
Crss	Reverse Transfer Capacitance			210		
ls	Continuous Source Current <sub>1,5</sub>	V V 0V 5			80	Α
ISM	Pulsed Source Current <sub>2,5</sub>	V <sub>G</sub> =V <sub>D</sub> =0V , Force Current			160	Α
VSD	Diode Forward Voltage2	V <sub>GS</sub> =0V , I <sub>S</sub> =1A , T <sub>J</sub> =25°C			1.2	٧
trr	Reverse Recovery Time	IE-20A dI/dt-400A/::- T.: 05°C		14		nS
Qrr	Reverse Recovery Charge	—IF=30A , dI/dt=100A/μs ,Tյ=25°C		5		nC

# Note:

- 1. The data tested by surface mounted on a 1 inch2 FR-4 board with 2OZ copper.
- 2. The data tested by pulsed, pulse width. The EAS data shows Max. rating.
- 3.The test cond ≤ 300us , duty cycle ition is VDD=25 ≤ V,V 2%GS =10V,L=0.1mH,IAS=53.8A
- 4. The power dissipation is limited by 175℃ junction temperature
- 5. The data is theoretically the same as ID and IDM, in real applications, should be limited by total power dissipation.



# **Typical Characteristics**

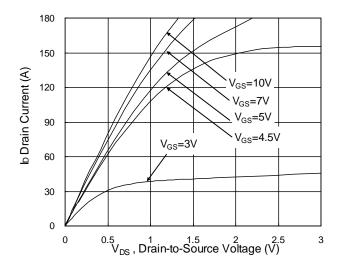


Fig.1 Typical Output Characteristics

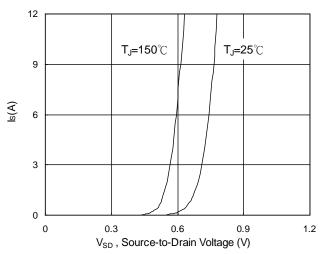


Fig.3 Forward Characteristics of Reverse

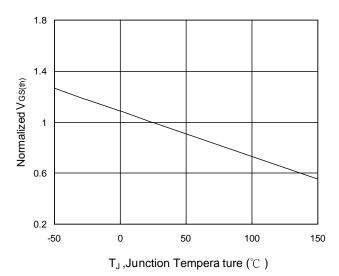


Fig.5 Normalized V<sub>GS(th)</sub> vs. T<sub>J</sub>

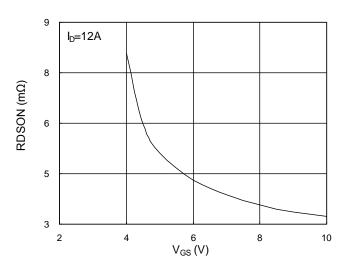


Fig.2 On-Resistance vs. G-S Voltage

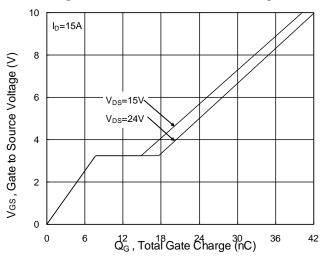


Fig.4 Gate-Charge Characteristics

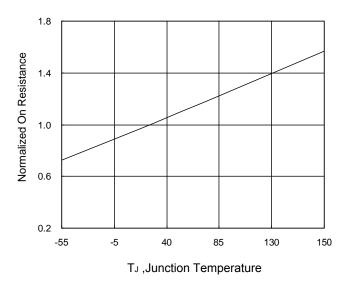
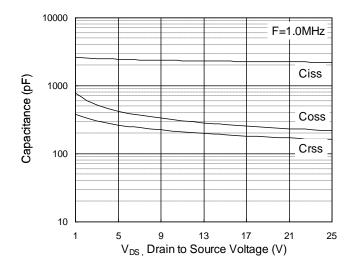


Fig.6 Normalized  $R_{DSON}$  vs.  $T_J$ 





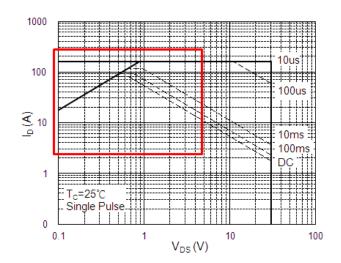


Fig.7 Capacitance

Normalized Thermal Response (Reac)

Fig.8 Safe Operating Area

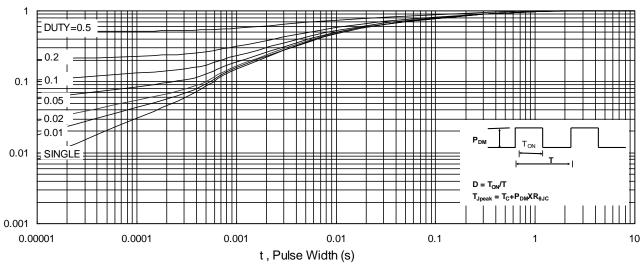
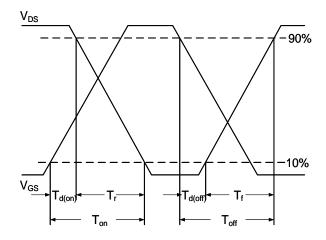
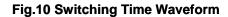


Fig.9 Normalized Maximum Transient Thermal Impedance





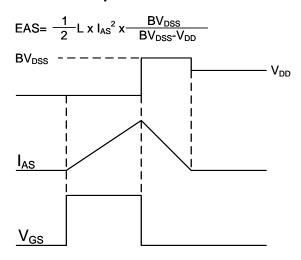


Fig.11 Unclamped Inductive Switching Waveform



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